Application/Control No. Applicant(s)/Patent Under Reexamination 10/649,850 KWON ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2818 Tan T. Nguyen **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 06-1992 Lim, Hank H. 365/189.11 US-5,122,986 Α 365/222 ₿ US-6,639,862 10-2003 Spirkl, Wolfgang С US-D US-Ε US-F US-US-G US-Н ı US-J US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Classification Name Country Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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